

<Full SiC Power Modules>

# FMF600DXE-34BN

HIGH POWER SWITCHING USE

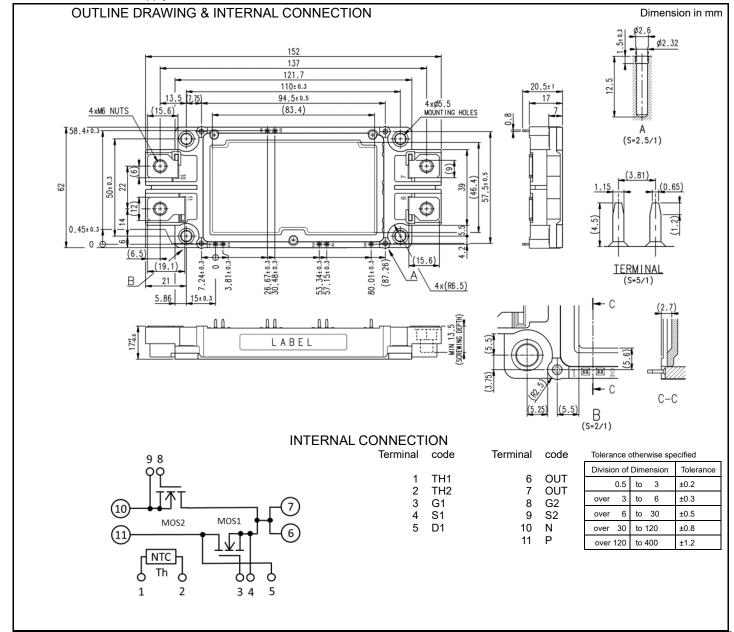
**INSULATED TYPE** 



- •Silicon Carbide MOSFET
- •Flat base Type
- •Copper base plate
- •RoHS Directive compliant
- •Recognized under UL1557, File E323585

#### **APPLICATION**

HF converter, Power supply, Motor drive, etc.



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INSULATED TYPE

Symbol	Item	Conditions	Rating	Unit
V <sub>DSX</sub>	Drain-source voltage	V <sub>GS</sub> =-7 V, Measurement terminals position(P-OUT, OUT-N) Refer to Switching characteristics test circuit		V
V <sub>GSS</sub>	Gate-source voltage	D-S short-circuited	+20/-8.5	V
I <sub>D</sub>	Duning assument	DC, T <sub>C</sub> =42°C (Note.2)	600	
I <sub>DRM</sub>	Drain current	Pulse, Repetitive (Note.3), T <sub>vj</sub> =150°C(Note.4)	1200	A
P <sub>tot</sub>	Total power dissipation	T <sub>C</sub> =25 °C (Note. 2)	2500	W
Is (Note1)	Course ourset	DC	600	
I <sub>SRM</sub> (Note1)	Source current  Pulse, Repetitive (Note.3), T <sub>vj</sub> =150°C(Note.4)		1200	A
V <sub>isol</sub>	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V
T <sub>vjmax</sub>	Maximum junction temperature	Instantaneous event (overload) (Note.11)	175	°C
T <sub>vjop</sub>	Operating junction temperature	Continuous operation (under switching) (Note.11)	-40~+150	°C
T <sub>Cmax</sub>	Maximum case temperature	(Note.2, 11)	125	°C
T <sub>stg</sub>	Storage temperature	-	-40~+125	°C

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

Symbol	Item	em Conditions (note10)			Limits		Unit
Symbol	item	Conditions	Conditions		Тур.	Max.	Offic
	Drain-source cut-off current	V <sub>DS</sub> =V <sub>DSX</sub> , V <sub>GS</sub> =-7 V		-	-	1.0	mΛ
I <sub>DSX</sub>	V <sub>DS</sub> =1000V, V <sub>GS</sub> =-7 V		-	-	1.0	mA	
$V_{GS(th)}$	Gate-source threshold voltage	I <sub>D</sub> =229 mA, V <sub>DS</sub> =10 V		1.8	2.5	3.2	V
I <sub>GSS</sub>	Gate-source leakage current	V <sub>GS</sub> =V <sub>GSS</sub> , D-S short-circuited		-	-	0.5	μΑ
			T <sub>vj</sub> =25 °C	-	1.62	2.75	
V <sub>DS(on)</sub>	Drain-source on-state voltage	I <sub>D</sub> =600 A, V <sub>GS</sub> =15V (Note.6)	T <sub>vj</sub> =125 °C	-	2.36	-	V
(terminal)			T <sub>vj</sub> =150 °C	-	2.65	-	
			T <sub>vj</sub> =25 °C	-	1.35	-	
$V_{DS(on)}$	Drain-source on-state voltage	I <sub>D</sub> =600 A, V <sub>GS</sub> =15V (Note.6)	T <sub>vj</sub> =125 °C	-	2.09	-	V
(chip)			T <sub>vj</sub> =150 °C	-	2.38	-	
	Drain-source on-state resistance		T <sub>vj</sub> =25 °C	-	2.25	-	mΩ
$r_{\text{DS(on)}}$		I <sub>D</sub> =600 A, V <sub>GS</sub> =15V (Note.6)	T <sub>vi</sub> =125 °C	-	3.48	-	
(chip)			T <sub>vi</sub> =150 °C	-	3.97	-	
Ciss	Input capacitance			-	55	-	nF
Coss	Output capacitance	V <sub>DS</sub> =10 V, V <sub>GS</sub> =0V	V <sub>DS</sub> =10 V. V <sub>GS</sub> =0V		23	-	
Crss	Reverse transfer capacitance			-	2	-	
Q <sub>G</sub>	Gate charge	V <sub>DD</sub> =900 V, I <sub>D</sub> =600 A, V <sub>GS</sub> =0→15	V <sub>DD</sub> =900 V, I <sub>D</sub> =600 A, V <sub>GS</sub> =0→15 V		1890	-	nC
t <sub>d(on)</sub>	Turn-on delay time			-	100	-	
t <sub>r</sub>	Rise time			-	60	-	ns
t <sub>d(off)</sub>	Turn-off delay time			-	190	-	
t <sub>f</sub>	Fall time	V <sub>DD</sub> =900 V, I <sub>D</sub> =600 A, V <sub>GS</sub> =+15 /	-7 \/ T.:−150°C	-	40	-	
t <sub>rr</sub> (Note1)	Reverse recovery time	$R_{G(on/off)} = 1.2 / 0.75 \Omega$ , $L_{s ext} = 13.2$		-	110	-	
Eon	Turn-on switching energy	Inductive load, per pulse		-	36	-	
E <sub>off</sub>	Turn-off switching energy			-	11	-	mJ
E <sub>rr</sub> (Note1)	Reverse recovery energy			-	18	-	
Q <sub>rr</sub> (Note1)	Reverse recovery charge			-	32	-	μC
			T <sub>vj</sub> =25 °C	-	4.47	5.50	,
V <sub>SD</sub> (Note.1) (terminal)	Source-drain voltage	$I_S=600~A^{(Note.6)}$ $V_{GS}=-7~V$	T <sub>vj</sub> =125 °C	-	4.11	-	V
			T <sub>vi</sub> =150 °C	-	4.04	-	
			T <sub>vi</sub> =25 °C	-	4.20	-	
$V_{\text{SD}}^{\text{(Note.1)}}$	Source-drain voltage	I <sub>S</sub> =600 A (Note.6) V <sub>GS</sub> =-7 V	T <sub>vj</sub> =125 °C	-	3.84	-	V
(chip)	Coaroo-drain voitage		T <sub>vi</sub> =150 °C	_	3.77	_	

Caution: Short-circuit capability is not designed.

#### <Full SiC Power Modules>

# FMF600DXE-34BN

# HIGH POWER SWITCHING USE

#### **INSULATED TYPE**

#### THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item Conditions	Conditions	Limits			Unit
		Min.	Тур.	Max.	Uill	
$R_{th(j-c)Q}$	Thermal resistance <sup>(Note. 2)</sup>	Junction to case, per inverter switch	1	1	60	K/kW
R <sub>th(c-s)</sub>	Contact thermal resistance <sup>(Note.2)</sup>	Case to heat sink, per 1 module,		15		K/kW
	Contact thermal resistance	Thermal grease applied (Note.8, 11)		15		r/KVV

#### NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
	item	Conditions	Min.	Тур.	/p. Max.	Offic
R <sub>25</sub>	Zero-power resistance	T <sub>C</sub> =25 °C (Note.2)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	T <sub>C</sub> =100 °C (Note.2) ,R <sub>100</sub> =493 Ω	-7.3	-	+7.8	%
B <sub>(25/50)</sub>	B-constant	Approximate by equation (Note.7)	-	3375	-	K
P <sub>25</sub>	Power dissipation	T <sub>C</sub> =25 °C (Note.2)	-	-	10	mW

#### **MODULE**

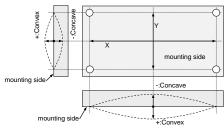
Cumbal	Itom	Conditions		Limits			Linit
Symbol	Item	Conditions		Min.	Тур.	Max.	Unit
$M_t$	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N·m
Ms		Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N·m
ec	Flatness of base plate	On the centerline X, Y (Note.5)		0	-	+100	μm

Symbol	Item	Conditions	Value	Unit
m	mass	-	415	g
۵	Clearance	Terminal to terminal	10.0	m.m.
da	Clearance	Terminal to base plate	8.2	mm
d	On an area distance	Terminal to terminal	17.4	mana
ds	Creepage distance	Terminal to base plate	16.0	mm
R <sub>DD'+SS'</sub>	Internal lead resistance	P-S1, OUT-S2 terminals, per switch	0.45	mΩ
Ls	Internal stray inductance	P-N	9	nH
r <sub>g</sub>	Internal gate resistance	Per switch	0.25	Ω

<sup>\*:</sup> This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.

Note1. Represent ratings and characteristics of the MOSFET body diode.

- 2. Case temperature (T<sub>C</sub>) and heat sink temperature (T<sub>s</sub>) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
- 3. Pulse width and repetition rate should be such that the device junction temperature (Tvj) does not exceed Tvjmax rating.
- 4. Junction temperature (T  $_{\nu\,j}$  ) should not increase beyond T  $_{\nu\,j\,m\,a\,x}$  rating.
- 5. The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.



6. Pulse width and repetition rate should be such as to cause negligible temperature rise.

7. 
$$B_{(25/50)} = ln(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} - \frac{1}{T_{50}})$$

 $R_{25}\!\!:$  resistance at absolute temperature  $T_{25}$  [K];  $T_{25}\!\!=\!\!25$  [°C]+273.15=298.15 [K]

 $R_{50}$ : resistance at absolute temperature  $T_{50}$  [K];  $T_{50}$ =50 [°C]+273.15=323.15 [K]

- 8. Reference value. Thermally conductive grease of  $\lambda$ =0.9 W/(m·K).
- 9. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

"φ2.6×10 or φ2.6×12, B1 tapping screw"

The length of the screw depends on the thickness (t1.6) of the PCB.

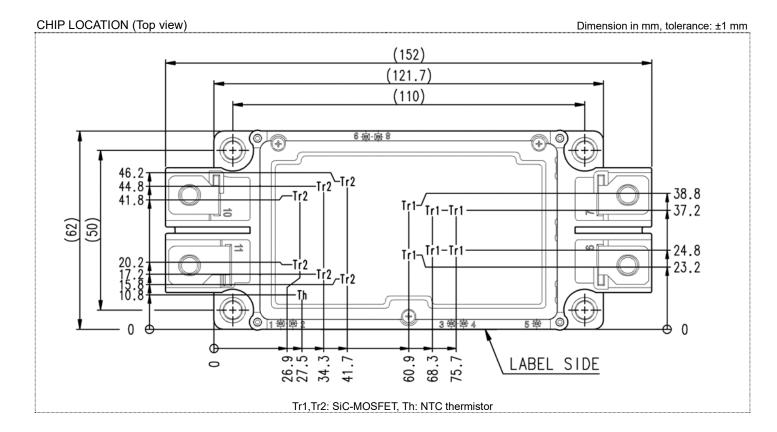
- 10. Per switch.
- 11. Long term performance related to thermal conductive grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition (T<sub>vj max</sub>, T<sub>vj op</sub>, T<sub>C max</sub>) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

HIGH POWER SWITCHING USE

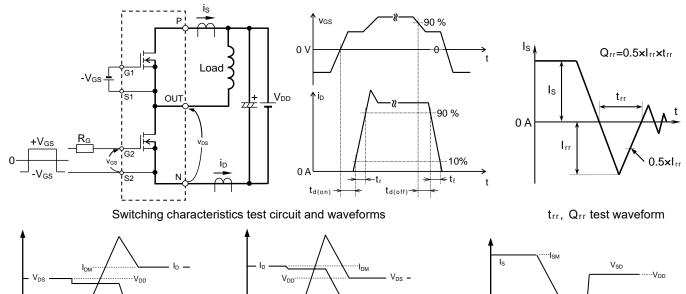
**INSULATED TYPE** 

Symbol	la	Item Conditions	Limits			l locit
	item		Min.	Тур.	Max.	Unit
$V_{DD}$	(DC) Supply voltage	Applied across P-N terminals	-	900	1200	V
V <sub>GS(+)</sub>	Gate-Source drive positive voltage	Applied across G1-S1, G2-S2 terminals	13.5	15	16.5	V
$V_{GS(-)}$	Gate-Source drive negative voltage	Applied across G1-S1, G2-S2 terminals	-8.5	-7	-5.5	V
R <sub>G(on)</sub>	External gate turn-on resistance (Note.12)	Per switch	1.2	-	6.0	Ω
R <sub>G(off)</sub>	External gate turn-off resistance (Note.12)	Per Switch	0.75	-	6.0	12

Note 12. The value of external gate resistance should be considered the surge voltage not to exceed the rating voltage in the worst system condition.







MOSFET Turn-on switching energy

0.1xl

MOSFET Turn-off switching energy

 $0.1xV_{DI}$ 

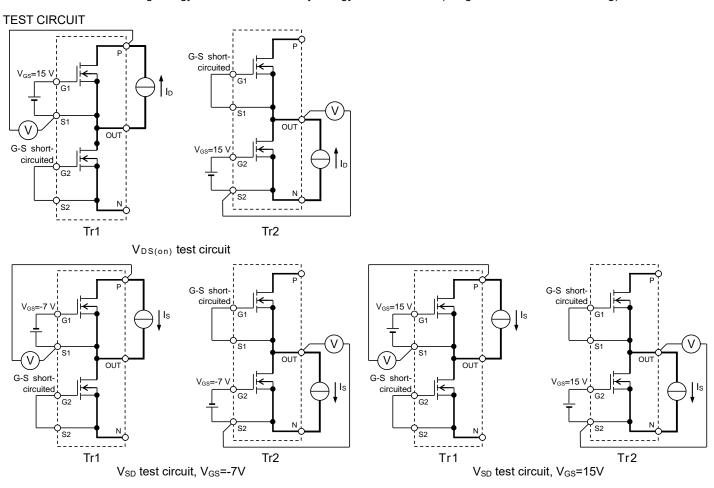
MOSFET body diode Reverse recovery energy

0 A

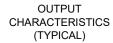
0 V

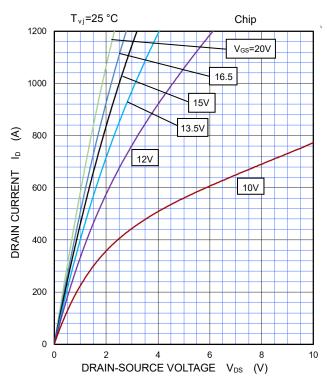
Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

0.02×I<sub>DM</sub>

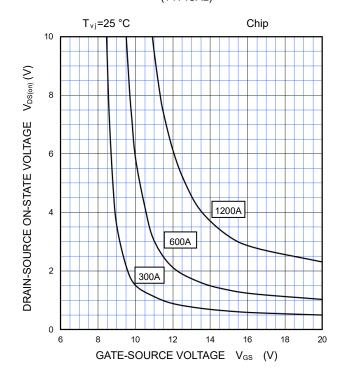


#### **PERFORMANCE CURVES**

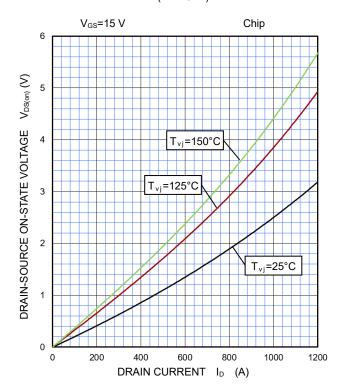




#### DRAIN-SOURCE ON STATE VOLTAGE CHARACTERISTICS (TYPICAL)



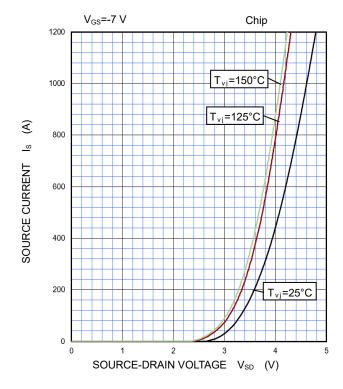
#### DRAIN-SOURCE ON STATE VOLTAGE CHARACTERISTICS (TYPICAL)



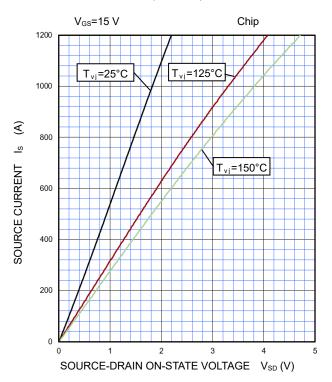
#### INSULATED TYPE

# PERFORMANCE CURVES MOSFET BODY DIODE

MOSFET BODY DIODE FORWARD CHARACTERISTICS (TYPICAL)

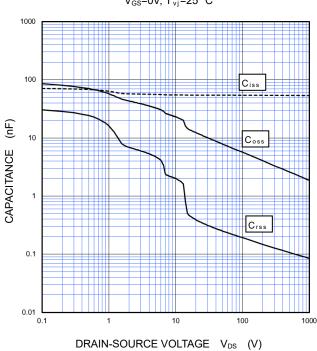


#### SOURCE-DRAIN ON STATE VOLTAGE CHARACTERISTICS (TYPICAL)

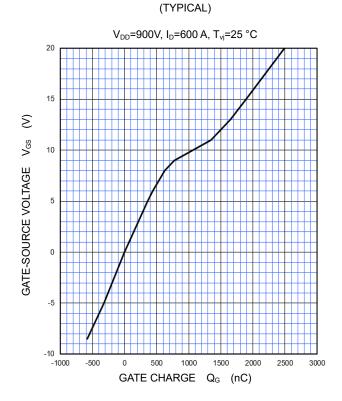


#### CAPACITANCE CHARACTERISTICS (TYPICAL)





### GATE CHARGE CHARACTERISTICS

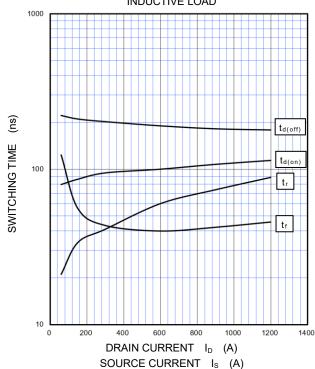


HIGH POWER SWITCHING USE INSULATED TYPE

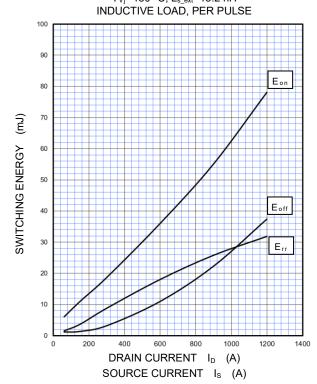
#### **PERFORMANCE CURVES**

#### HALF-BRIDGE SWITCHING CHARACTERISTICS

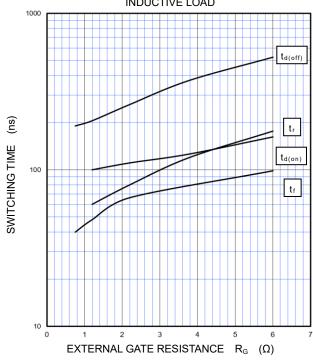
 $\label{eq:typical} \begin{array}{c} \text{(TYPICAL)} \\ \text{V}_{\text{DD}}\text{=}900 \text{ V}, \text{ V}_{\text{GS}}\text{=}15 \text{ / -7 V}, \text{ R}_{\text{G(on/off)}}\text{=}1.2 \text{ / }0.75\Omega, \\ \text{T}_{\text{vj}}\text{=}150 \text{ °C}, \text{ L}_{\text{s\_ext}}\text{=}13.2 \text{ nH} \\ \text{INDUCTIVE LOAD} \end{array}$ 



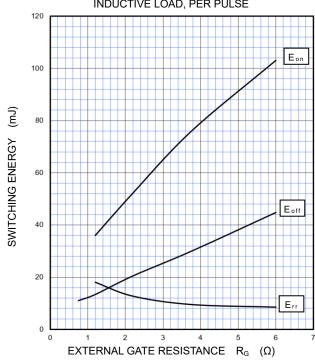
# $\begin{array}{c} \text{HALF-BRIDGE} \\ \text{SWITCHING CHARACTERISTICS} \\ \text{(TYPICAL)} \\ \text{V}_{\text{DD}} = 900 \text{ V, V}_{\text{GS}} = 15 \ / \ -7 \text{ V, R}_{\text{G(on/off)}} = 1.2 \ / \ 0.75\Omega, \\ \text{T}_{\text{Vj}} = 150 \ ^{\circ}\text{C, L}_{\text{s\_ext}} = 13.2 \ \text{nH} \end{array}$



# $\begin{array}{c} \text{HALF-BRIDGE} \\ \text{SWITCHING CHARACTERISTICS} \\ \text{(TYPICAL)} \\ \text{V}_{\text{DD}} = 900 \text{ V, V}_{\text{GS}} = 15 \text{ / -7 V, I}_{\text{D}} = 600 \text{ A,} \\ \text{T}_{\text{vj}} = 150 \text{ °C, L}_{\text{s\_ext}} = 13.2 \text{ nH} \\ \text{INDUCTIVE LOAD} \end{array}$



# $\begin{array}{c} \text{HALF-BRIDGE} \\ \text{SWITCHING CHARACTERISTICS} \\ \text{(TYPICAL)} \\ \text{V}_{\text{DD}} = 900 \text{ V, V}_{\text{GS}} = 15 \text{ / -7 V, I}_{\text{D}} = 600 \text{ A,} \\ \text{T}_{\text{Vj}} = 150 \text{ °C, L}_{\text{s\_ext}} = 13.2 \text{ nH} \\ \text{INDUCTIVE LOAD, PER PULSE} \end{array}$



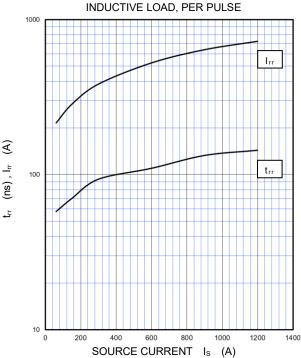
HIGH POWER SWITCHING USE

#### INSULATED TYPE

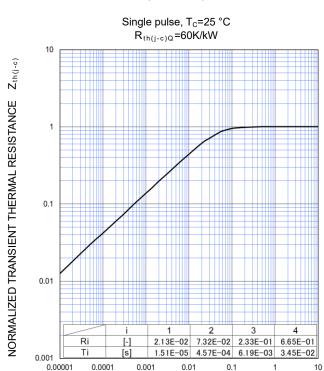
#### **PERFORMANCE CURVES**

MOSFET BODY DIODE
REVERSE RECOVERY CHARACTERISTICS
(TYPICAL)

 $\begin{array}{c} V_{\text{DD}}\text{=}900 \text{ V, } V_{\text{GS}}\text{=}15 \text{ / -7 V, } R_{\text{G(on/off)}}\text{=}1.2 \text{ / } 0.75\Omega, \\ T_{vj}\text{=}150 \text{ °C, } L_{s\_\text{ext}}\text{=}13.2 \text{ nH} \end{array}$ 



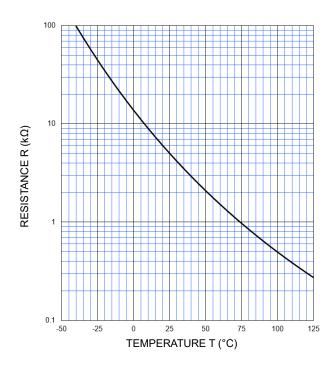
TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



TIME (S)

#### NTC thermistor part

TEMPERATURE CHARACTERISTICS (TYPICAL)



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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HIGH POWER SWITCHING USE INSULATED TYPE

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Publication Date : August 2023